

# XBM3212 Series

# Li-ion/Polymer 2-Cell Protector

# GENERAL DESCRIPTION

XBM3212 Series is a protection IC for 2 serial-cell lithium-ion / lithium polymer recharge able batteries and includes high accuracy voltage detection circuits and delay circuits. XBM3212 Series is suitable for protecting 2 serial-cell rechargeable lithium-ion / lithium polymer battery packs from overcharge, over-discharge, overcurrent and short-circuiting.

1s

8ms

## FEATURES

- Manufactured with High Voltage Tolerant Process .
- Low supply current •
- 8µA(I<sub>q</sub>) 2-Cell voltage7.2V Typ. .
- 2-Cell voltage4.0V Typ. 3.3µA(Isd) •
- SOT23-6 Package •
- Variety of detector threshold •
- Over-charge detector threshold-V<sub>cu</sub>:3.6V-4.5V step of 0.1V ±25mV • ±50mV
- Overcharge Release Voltage-V<sub>cL</sub>=V<sub>cu</sub>-0.2V •
- Over-discharge detector threshold V<sub>DL</sub>:2.1V-3.0V step of 0.1V • ±80mV
- Over-discharge Release Voltage-VDR •
- Discharge-current threshold1 0.1V .
- 1.0V (Fixed) Short detector threshold .
- Charge-current threshold -0.1V •
- Over-discharge self-recovery function .
- Broken line protection function •
- Over-charge detector Output Delay •
- Over-discharge detector Output Delay 100ms • 8ms
- Discharge-current detector Output Delay •
- Charge-current detector Output Delay •
- Short Circuit detector Output Delay 130us •
- **OV Battery Charging Function** •
- ESD HBM: 4KV •
- **RoHS Compliant and Lead Pb Free** •

# APPLICATIONS

- Power Tools .
- E-Bike
- Power Bank .
- Power Amplifier •
- 2 Cell Lithium-ion or Lithium polymer rechargeable battery pack •
- Lithium iron phosphate battery

±100mV

Maximum Rating 30V







## **ORDERING INFORMATION**

PART NUMBER	OCV [VCU] (V)	OCRV [VCL] (V)	ODV [VDL] (V)	ODRV [VDR] (V)	TOP MARK
XBM3212RKK	3.65±25mV	3.45±50mV	2.10±80mV	2.50±100mV	YWTxxx
XBM3212DBA	4.28±25mV	4.08±50mV	2.9±80mV	3.0±100mV	YWTxxx
XBM3212DGB	4.28±25mV	4.08±50mV	2.4±80mV	2.95±100mV	YWTxxx
XBM3212DCA	4.28±25mV	4.08±50mV	2.8±80mV	3.0±100mV	YWTxxx
XBM3212BCA	4.25±25mV	4.05±50mV	2.8±80mV	3.0±100mV	YWTxxx
XBM3212JFG	4.425±25mV	4.225±50mV	2.5±80mV	2.7±100mV	YWTxxx

Note: "YWTxxx" is manufacture date code, "Y" means the year, "W" means the week, "T" means the times of odering, "xxx" is internal product code of XySemi.



## **PIN CONFIGURATION**



Figure 2. PIN Configuration

#### **PIN DESCRIPTION**

PIN NUMBER	PIN NAME	PIN DESCRIPTION
1	OD	Connection pin of discharge control FET gate (CMOS output)
2	OC	Connection pin of charge control FET gate (CMOS output)
3	VM	Voltage detection pin between VM pin and VSS pin (Overcurrent / charger detection pin)
4	V1	Positive terminal Pin for Cell-1
5	V2	Positive terminal Pin for Cell-2
6	VSS	VSS pin. Ground pin for the IC

#### **ABSOLUTE MAXIMUM RATINGS**

(NOTE: DO NOT EXCEED THESE LIMITS TO PREVENT DAMAGE TO THE DEVICE. EXPOSURE TO ABSOLUTE MAXIMUM RATING CONDITIONS FOR LONG PERIODS MAY AFFECT DEVICE RELIABIL-

PARAMETER	VALUE	UNIT
V2; VM	-0.3~30	V
oc	VSS-0.3~VSS+30	V
OD	VSS+0.3~V2+0.3	V
Operating Ambient Temperature	-40 to 85	°C
Maximum Junction Temperature	125	°C
Storage Temperature	-55 to 150	°C
Lead Temperature ( Soldering, 10 sec)	300	°C
Power Dissipation at T=25°C	0.25	W
Package Thermal Resistance (Junction to Ambient) $\theta$ JA	350	°C/W
Package Thermal Resistance (Junction to Case) $\theta$ JC	50	°C/W
ESD(HBM)	4000	V



## **ELECTRICAL CHARACTERISTICS**

Typical and limits appearing in normal type apply for TA = 25°C, unless otherwise specified.

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	ТҮР	МАХ	UNIT
Detection Voltage						
Charger Detection Voltage	Vсна		-0.08	-0.10	-0.12	V
Discharger Detection Voltage	VDIS		0.08	0.10	0.12	V
Current Consumption						
Current Consumption in Normal Operation	IOPE	VDD=7.2V VM =0V		8	10	μA
Current Consumption in Power Down	IPD	VDD=4.0V VM pin floating		3.3	5	μA
Detection Delay Time						
Overcharge Voltage Detection De- layTime	tcu		800	1000	1200	mS
Overdischarge Voltage Detection Delay Time	tDL		80	100	120	mS
Overdischarge Current Detection Delay Time	tiov		6	8	10	mS
Overcharge Current Detection De- lay Time	ticv		6	8	10	mS
Load Short-Circuiting Detection Delay Time	*tshort		100	130	160	μS

Note1: \*---The parameter is guaranteed by design.

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## FUNCTIONAL BLOCK DIAGRAM



Figure 3. Functional Block Diagram

## OPERATION

#### **Over-charge detectors**

While the cell is charged, the voltage b etween V1 pin and VSS pin (voltage of the Cell-1), the voltage between V2 pin and V1 pin (voltage of the Cell-2) are supervised. If at least one of the cells' voltage becomes e qual or more than the over-charge detector threshold, the over-charge is detected, and an external charge control N-MOSFET turn s off with OC pin being at "L" level via an e xternal pull-down resister and charge stop s.

To reset the over-charge and make the OC pin level to "H" again after detecting ov er-charge, in such conditions that a time when all the cells' voltages are down to a lev el lower than over-charge released voltage. The output voltage of OC pin becomes "H", and it makes an external N-MOSFET turns on, and charge cycle is available. The over charge detectors have hysteresis. Internal f ixed output delay times for overcharge dete ction and release from overcharge exist. E ven if one of voltage of Cells keeps its level more than the over-charge detector thresh old, and output delay time passes, overcha rge voltage is detected. Even when the volt age of each cell becomes equal or higher I evel than  $V_{CU}$  if these voltages would be ba ck to a level lower than the overcharge det ector threshold within a time period of the o utput delay time, the overcharge is not dete cted. Besides, after detecting over-charge, each cell voltage is lower than the overchar ge detector released voltage, even if just o ne of cells' voltage becomes equal or more than the over-charge released voltage withi n the released output delay time, overchar ge is not released.



#### **Over-discharge detectors**

While the cells are discharged, the volt -age between V1 pin and VSS pin (the volt age of Cell-1), the voltage between V2 pin and V1 pin (Cell-2 voltage) are supervised. If at least one of the cells' voltage becomes equal or less than the over-discharge detec tor threshold, the over-discharge is detecte d and discharge stops by the external disc harge control N-MOSFET turning off with t he OD pin being at "L". The condition to rel ease over-discharge voltage detector is tha t after detecting over-discharge voltage, all the cells' voltage becomes higher than the over-discharge released voltage, OD pin b ecomes "H" level, and by turning on the ext ernal N-MOSFET, discharge becomes pos sible. The over-discharge detectors have h ysteres-is.

Internal fixed output delay times for ov ercharge detection and release from over-c harge exist. If at least one of the voltage of Cells is down to equal or lower than the ov er-discharge detector threshold, if the volta ge of each Cell would be back to a level hi gher than the over-discharge detector thres hold within a time period of the output dela y time, the over-discharge is not detected. Output delay time for release from over-dis charge is also set internally. After detecting over-discharge, supply current would be re duced and be into standby by halting unne cessary circuits and consumption current o f the IC itself is made as small as possible.

#### Discharge-current Detector, & Short Circuit Protector

When the discharge is acceptable, VM voltage is supervised, if the load is short an d VM voltage becomes equal or more than excess discharge current threshold, and equal or less than short detector threshold, th e status becomes excess discharge curren t detected condition. If VM voltage become s equal or more than short circuit detector t hreshold, the status becomes short circuit detector t hreshold, the status becomes short circuit detected, then OD pin outputs "L" and by t urning off the external MOSFET, large current flow is prevented. The excess discharge e current detector has the fixed output delay time.

#### **Charge-current detector**

When the charge is acceptable, VM vo Itage is supervised, if the VM voltage beco mes equal or more than excess charge cur rent threshold the status becomes excess charge current detected condition. then OC pin outputs "L" and by turning off the extern al MOSFET, large current flow is prevente d. Output delay of excess charge current is internally fixed.

#### **Over-discharge self-recovery function**

In normal working conditions, when th e battery voltage drops below the discharg e detection voltage, and the duration of this state exceeds the excess discharge detecti on delay time, the chip will turn off the MO SFET (OD terminal) for discharge control a nd stop discharging.



# PACKAGE OUTLINE(SOT23-6)



Symbol	Dimensions I	n Millimetres	Dimensions In Inches		
	Min	Max	Min	Max	
А	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
с	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E	1.500	1.700	0.059	0.067	
E1	2.650	2.950	0.104	0.116	
е	0.950(BSC)		0.037(BSC)		
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	

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